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"[Embedded - Microcontrollers](#)" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "[Embedded - Microcontrollers](#)"

Details

Product Status	Active
Core Processor	STM8
Core Size	8-Bit
Speed	24MHz
Connectivity	I ² C, IrDA, LINbus, SPI, UART/USART
Peripherals	Brown-out Detect/Reset, POR, PWM, WDT
Number of I/O	34
Program Memory Size	64KB (64K x 8)
Program Memory Type	FLASH
EEPROM Size	1.5K x 8
RAM Size	6K x 8
Voltage - Supply (Vcc/Vdd)	2.95V ~ 5.5V
Data Converters	A/D 9x10b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 125°C (TA)
Mounting Type	Surface Mount
Package / Case	44-LQFP
Supplier Device Package	44-LQFP (10x10)
Purchase URL	https://www.e-xfl.com/product-detail/stmicroelectronics/stm8s207s8t3c

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4.5 Clock controller

The clock controller distributes the system clock (f_{MASTER}) coming from different oscillators to the core and the peripherals. It also manages clock gating for low power modes and ensures clock robustness.

Features

- **Clock prescaler:** To get the best compromise between speed and current consumption the clock frequency to the CPU and peripherals can be adjusted by a programmable prescaler.
- **Safe clock switching:** Clock sources can be changed safely on the fly in run mode through a configuration register. The clock signal is not switched until the new clock source is ready. The design guarantees glitch-free switching.
- **Clock management:** To reduce power consumption, the clock controller can stop the clock to the core, individual peripherals or memory.
- **Master clock sources:** Four different clock sources can be used to drive the master clock:
 - 1-24 MHz high-speed external crystal (HSE)
 - Up to 24 MHz high-speed user-external clock (HSE user-ext)
 - 16 MHz high-speed internal RC oscillator (HSI)
 - 128 kHz low-speed internal RC (LSI)
- **Startup clock:** After reset, the microcontroller restarts by default with an internal 2 MHz clock (HSI/8). The prescaler ratio and clock source can be changed by the application program as soon as the code execution starts.
- **Clock security system (CSS):** This feature can be enabled by software. If an HSE clock failure occurs, the internal RC (16 MHz/8) is automatically selected by the CSS and an interrupt can optionally be generated.
- **Configurable main clock output (CCO):** This outputs an external clock for use by the application.

Table 3. Peripheral clock gating bit assignments in CLK_PCKENR1/2 registers

Bit	Peripheral clock						
PCKEN17	TIM1	PCKEN13	UART3	PCKEN27	beCAN	PCKEN23	ADC
PCKEN16	TIM3	PCKEN12	UART1	PCKEN26	Reserved	PCKEN22	AWU
PCKEN15	TIM2	PCKEN11	SPI	PCKEN25	Reserved	PCKEN21	Reserved
PCKEN14	TIM4	PCKEN10	I ² C	PCKEN24	Reserved	PCKEN20	Reserved

4.12 TIM4 - 8-bit basic timer

- 8-bit autoreload, adjustable prescaler ratio to any power of 2 from 1 to 128
- Clock source: CPU clock
- Interrupt source: 1 x overflow/update

Table 4. TIM timer features

Timer	Counter size (bits)	Prescaler	Counting mode	CAPCOM channels	Complem. outputs	Ext. trigger	Timer synchronization/chaining
TIM1	16	Any integer from 1 to 65536	Up/down	4	3	Yes	No
TIM2	16	Any power of 2 from 1 to 32768	Up	3	0	No	
TIM3	16	Any power of 2 from 1 to 32768	Up	2	0	No	
TIM4	8	Any power of 2 from 1 to 128	Up	0	0	No	

4.13 Analog-to-digital converter (ADC2)

STM8S20xxx performance line products contain a 10-bit successive approximation A/D converter (ADC2) with up to 16 multiplexed input channels and the following main features:

- Input voltage range: 0 to V_{DDA}
- Dedicated voltage reference (VREF) pins available on 80 and 64-pin devices
- Conversion time: 14 clock cycles
- Single and continuous modes
- External trigger input
- Trigger from TIM1 TRGO
- End of conversion (EOC) interrupt

4.14 Communication interfaces

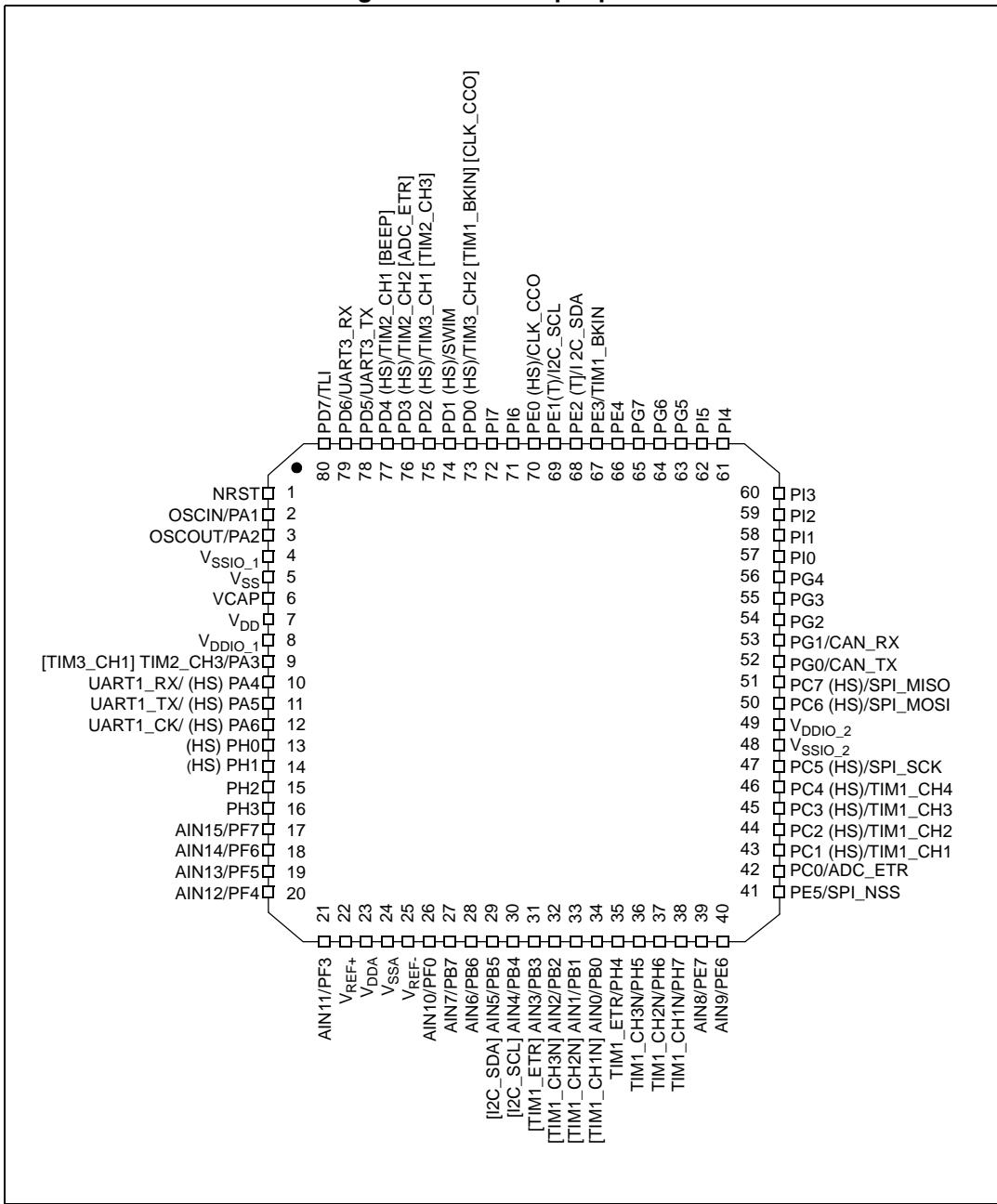
The following communication interfaces are implemented:

- UART1: Full feature UART, SPI emulation, LIN2.1 master capability, Smartcard mode, IrDA mode, single wire mode.
- UART3: Full feature UART, LIN2.1 master/slave capability
- SPI: Full and half-duplex, 10 Mbit/s
- I²C: Up to 400 Kbit/s
- beCAN (rev. 2.0A,B) - 3 Tx mailboxes - up to 1 Mbit/s

5 Pinouts and pin description

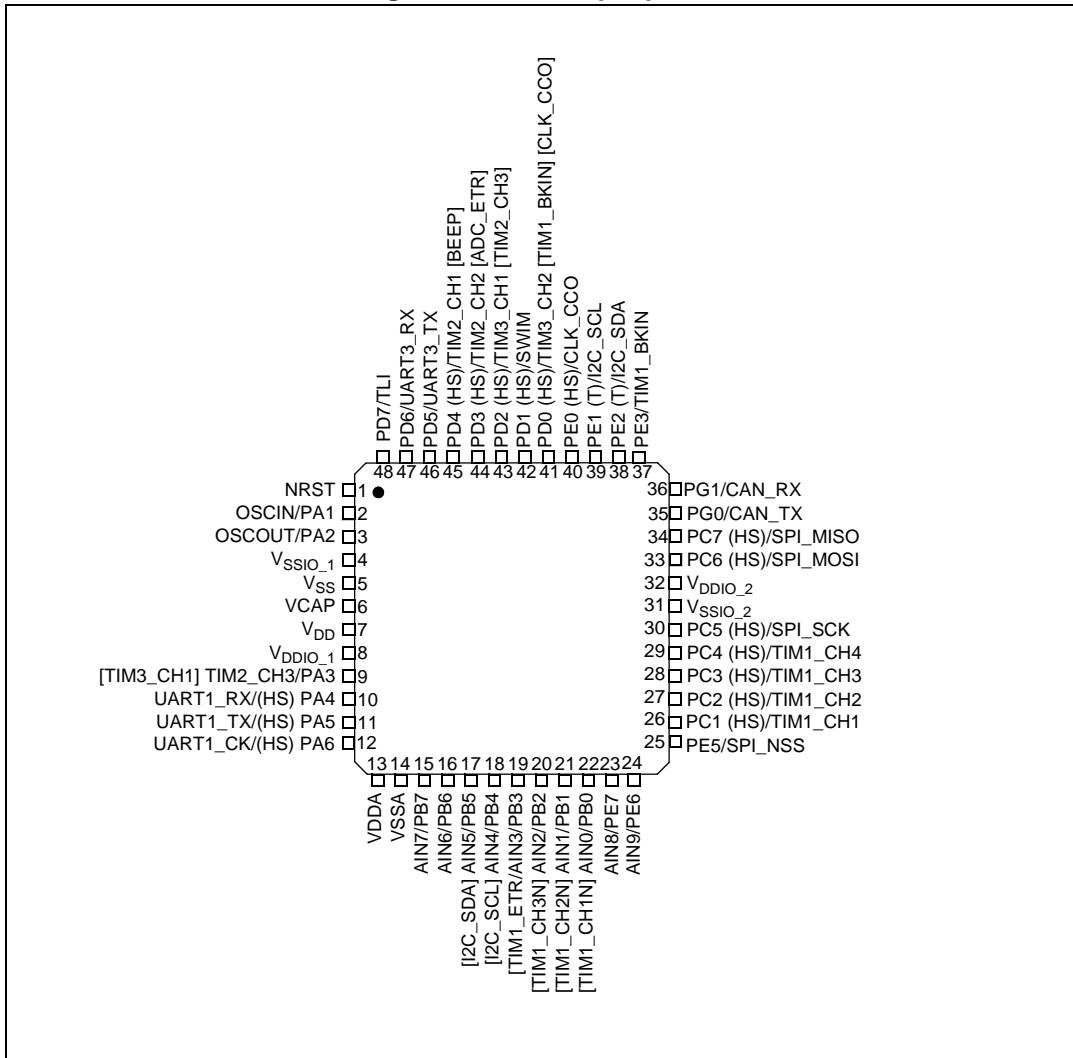
5.1 Package pinouts

Figure 3. LQFP 80-pin pinout



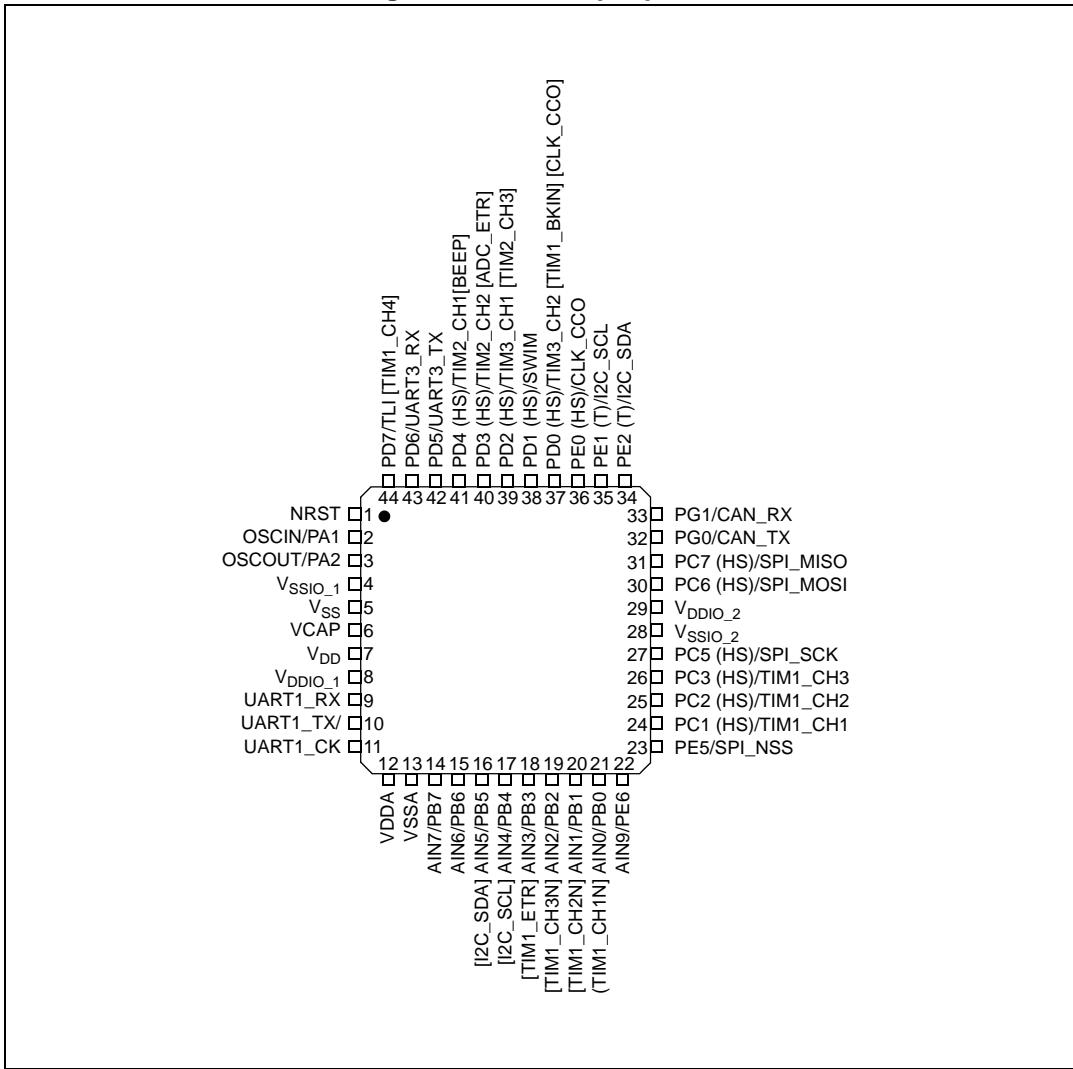
1. (HS) high sink capability.
2. (T) True open drain (P-buffer and protection diode to V_{DD} not implemented).
3. [] alternate function remapping option (If the same alternate function is shown twice, it indicates an exclusive choice not a duplication of the function).
4. CAN_RX and CAN_TX is available on STM8S208xx devices only.

Figure 5. LQFP 48-pin pinout



- (HS) high sink capability.
- (T) True open drain (P-buffer and protection diode to V_{DD} not implemented).
- [] alternate function remapping option (If the same alternate function is shown twice, it indicates an exclusive choice not a duplication of the function).
- CAN_RX and CAN_TX is available on STM8S208xx devices only.

Figure 6. LQFP 44-pin pinout



1. (HS) high sink capability.
2. (T) True open drain (P-buffer and protection diode to V_{DD} not implemented).
3. [] alternate function remapping option (If the same alternate function is shown twice, it indicates an exclusive choice not a duplication of the function).
4. CAN_RX and CAN_TX is available on STM8S208xx devices only.

Table 5. Legend/abbreviations for pinout table

Type	I = Input, O = Output, S = Power supply								
Level	Input	CM = CMOS							
	Output	HS = High sink							
Output speed	O1 = Slow (up to 2 MHz) O2 = Fast (up to 10 MHz) O3 = Fast/slow programmability with slow as default state after reset O4 = Fast/slow programmability with fast as default state after reset								
Port and control configuration	Input	float = floating, wpu = weak pull-up							
	Output	T = True open drain, OD = Open drain, PP = Push pull							
Reset state	Bold X (pin state after internal reset release) Unless otherwise specified, the pin state is the same during the reset phase and after the internal reset release.								

Table 6. Pin description

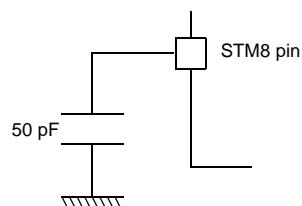
LQFP80	Pin number					Pin name	Type	Input		Output			Main function (after reset)	Default alternate function	Alternate function after remap [option bit]		
	LQFP64	LQFP48	LQFP44	LQFP32				floating	wpu	Ext. interrupt	High sink	Speed	OD	PP			
1	1	1	1	1	1	NRST	I/O	X							Reset		
2	2	2	2	2	2	PA1/OSCIN	I/O	X	X		O1	X	X		Port A1	Resonator/crystal in	
3	3	3	3	3	3	PA2/OSCOUT	I/O	X	X	X	O1	X	X		Port A2	Resonator/crystal out	
4	4	4	4	4	-	V _{SSIO_1}	S								I/O ground		
5	5	5	5	5	4	V _{SS}	S								Digital ground		
6	6	6	6	5	5	VCAP	S								1.8 V regulator capacitor		
7	7	7	7	6	6	V _{DD}	S								Digital power supply		
8	8	8	8	7	7	V _{DDIO_1}	S								I/O power supply		
9	9	9	-	-	-	PA3/TIM2_CH3	I/O	X	X	X	O1	X	X	Port A3	Timer 2 - channel3	TIM3_CH1 [AFR1]	
10	10	10	9	-	-	PA4/UART1_RX (1)	I/O	X	X	X	HS	O3	X	X	Port A4	UART1 receive	
11	11	11	10	-	-	PA5/UART1_TX	I/O	X	X	X	HS	O3	X	X	Port A5	UART1 transmit	

10.1.5 Pin loading conditions

10.1.6 Loading capacitor

The loading conditions used for pin parameter measurement are shown in [Figure 10](#).

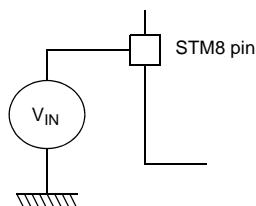
Figure 10. Pin loading conditions



10.1.7 Pin input voltage

The input voltage measurement on a pin of the device is described in [Figure 11](#).

Figure 11. Pin input voltage



10.3.2 Supply current characteristics

The current consumption is measured as described in [Figure 9 on page 52](#).

Total current consumption in run mode

The MCU is placed under the following conditions:

- All I/O pins in input mode with a static value at V_{DD} or V_{SS} (no load)
- All peripherals are disabled (clock stopped by Peripheral Clock Gating registers) except if explicitly mentioned.
- When the MCU is clocked at 24 MHz, $T_A \leq 105^\circ\text{C}$ and the WAITSTATE option bit is set.

Subject to general operating conditions for V_{DD} and T_A .

Table 20. Total current consumption with code execution in run mode at $V_{DD} = 5\text{ V}$

Symbol	Parameter	Conditions		Typ	Max	Unit
$I_{DD(\text{RUN})}$	Supply current in run mode, code executed from RAM	$f_{\text{CPU}} = f_{\text{MASTER}} = 24\text{ MHz}$, $T_A \leq 105^\circ\text{C}$	HSE crystal osc. (24 MHz)	4.4		mA
			HSE user ext. clock (24 MHz)	3.7	7.3 ⁽¹⁾	
		$f_{\text{CPU}} = f_{\text{MASTER}} = 16\text{ MHz}$	HSE crystal osc. (16 MHz)	3.3		
			HSE user ext. clock (16 MHz)	2.7	5.8	
			HSI RC osc. (16 MHz)	2.5	3.4	
			HSE user ext. clock (16 MHz)	1.2	4.1 ⁽¹⁾	
			HSI RC osc. (16 MHz)	1.0	1.3 ⁽¹⁾	
	Supply current in run mode, code executed from Flash	$f_{\text{CPU}} = f_{\text{MASTER}}/128 = 125\text{ kHz}$	HSI RC osc. (16 MHz/8)	0.55		
		$f_{\text{CPU}} = f_{\text{MASTER}} = 128\text{ kHz}$	LSI RC osc. (128 kHz)	0.45		
		$f_{\text{CPU}} = f_{\text{MASTER}} = 24\text{ MHz}$, $T_A \leq 105^\circ\text{C}$	HSE crystal osc. (24 MHz)	11.4		
			HSE user ext. clock (24 MHz)	10.8	18 ⁽¹⁾	
		$f_{\text{CPU}} = f_{\text{MASTER}} = 16\text{ MHz}$	HSE crystal osc. (16 MHz)	9.0		
			HSE user ext. clock (16 MHz)	8.2	15.2 ⁽¹⁾	
			HSI RC osc. (16 MHz)	8.1	13.2 ⁽¹⁾	
		$f_{\text{CPU}} = f_{\text{MASTER}} = 2\text{ MHz}$	HSI RC osc. (16 MHz/8) ⁽²⁾	1.5		
		$f_{\text{CPU}} = f_{\text{MASTER}}/128 = 125\text{ kHz}$	HSI RC osc. (16 MHz)	1.1		
		$f_{\text{CPU}} = f_{\text{MASTER}}/128 = 15.625\text{ kHz}$	HSI RC osc. (16 MHz/8)	0.6		
		$f_{\text{CPU}} = f_{\text{MASTER}} = 128\text{ kHz}$	LSI RC osc. (128 kHz)	0.55		

1. Data based on characterization results, not tested in production.

2. Default clock configuration measured with all peripherals off.

Low speed internal RC oscillator (LSI)

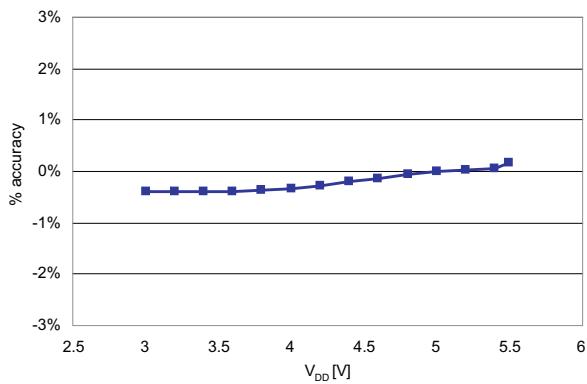
Subject to general operating conditions for V_{DD} and T_A .

Table 34. LSI oscillator characteristics

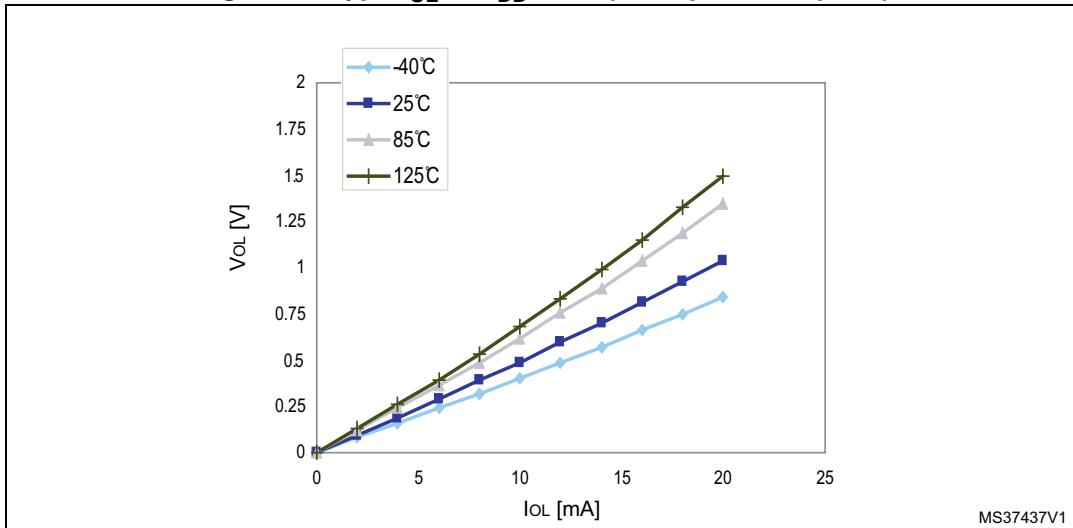
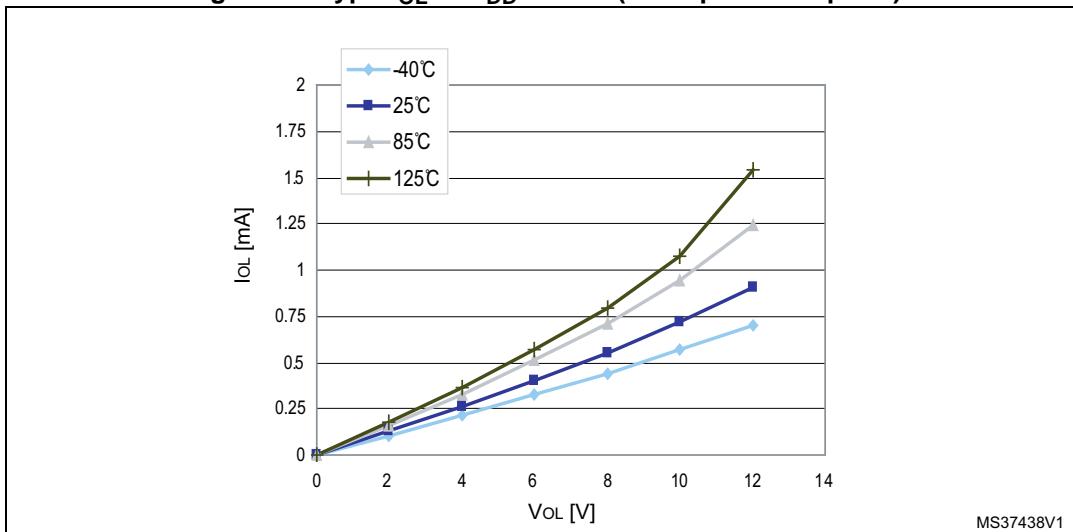
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
f_{LSI}	Frequency		110	128	146	kHz
$t_{su(LSI)}$	LSI oscillator wakeup time				7 ⁽¹⁾	μs
$I_{DD(LSI)}$	LSI oscillator power consumption			5		μA

1. Guaranteed by design, not tested in production.

Figure 19. Typical LSI frequency variation vs V_{DD} @ 25 °C



ai15070

Figure 25. Typ. V_{OL} @ $V_{DD} = 5$ V (true open drain ports)**Figure 26. Typ. V_{OL} @ $V_{DD} = 3.3$ V (true open drain ports)**

10.3.8 SPI serial peripheral interface

Unless otherwise specified, the parameters given in [Table 42](#) are derived from tests performed under ambient temperature, f_{MASTER} frequency and V_{DD} supply voltage conditions. $t_{MASTER} = 1/f_{MASTER}$.

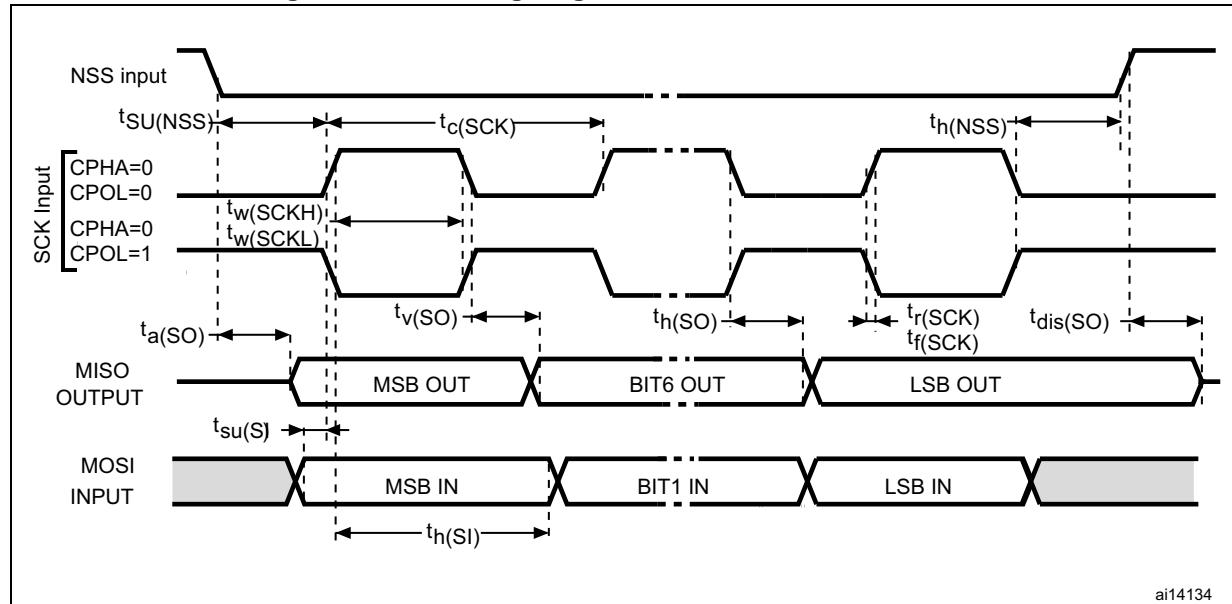
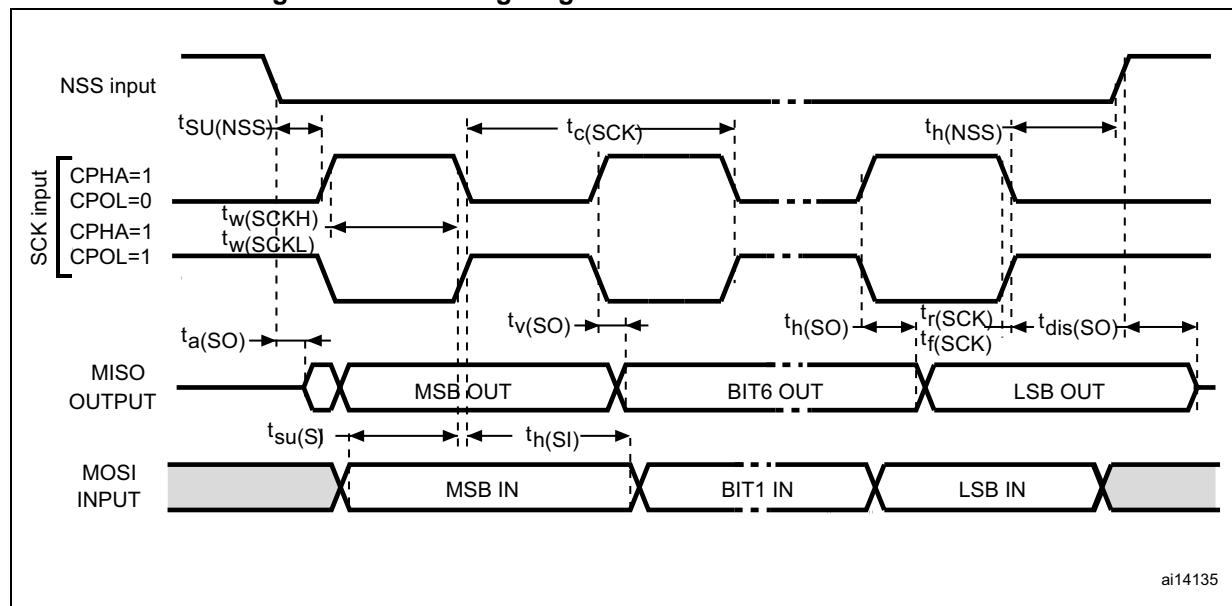
Refer to I/O port characteristics for more details on the input/output alternate function characteristics (NSS, SCK, MOSI, MISO).

Table 42. SPI characteristics

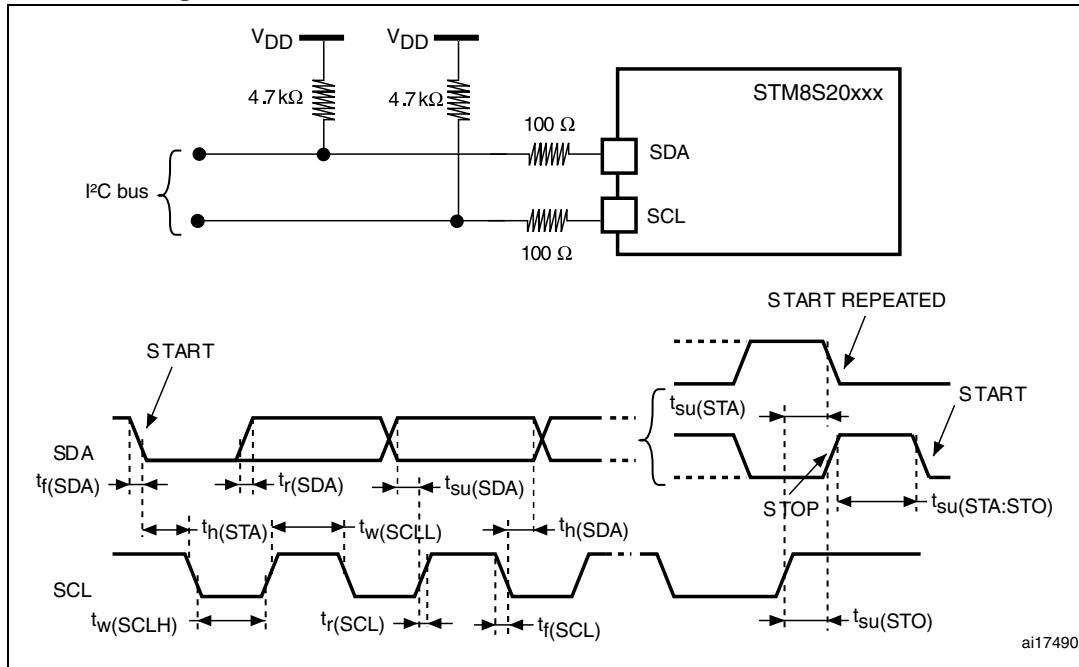
Symbol	Parameter	Conditions	Min	Max	Unit
f_{SCK} $1/t_c(SCK)$	SPI clock frequency	Master mode	0	10	MHz
		Slave mode	0	6	
$t_r(SCK)$ $t_f(SCK)$	SPI clock rise and fall time	Capacitive load: C = 30 pF		25	
$t_{su(NSS)}^{(1)}$	NSS setup time	Slave mode	$4 \times t_{MASTER}$		ns
$t_h(NSS)^{(1)}$	NSS hold time	Slave mode		70	
$t_w(SCKH)^{(1)}$ $t_w(SCKL)^{(1)}$	SCK high and low time	Master mode	$t_{SCK}/2 - 15$	$t_{SCK}/2 + 15$	
$t_{su(MI)}^{(1)}$ $t_{su(SI)}^{(1)}$	Data input setup time	Master mode	5		
		Slave mode	5		
$t_h(MI)^{(1)}$ $t_h(SI)^{(1)}$	Data input hold time	Master mode	7		
		Slave mode	10		
$t_a(SO)^{(1)(2)}$	Data output access time	Slave mode		$3 \times t_{MASTER}$	
$t_{dis(SO)}^{(1)(3)}$	Data output disable time	Slave mode		25	
$t_v(SO)^{(1)}$	Data output valid time	Slave mode (after enable edge)		75	
$t_v(MO)^{(1)}$	Data output valid time	Master mode (after enable edge)		30	
$t_h(SO)^{(1)}$	Data output hold time	Slave mode (after enable edge)	31		
$t_h(MO)^{(1)}$		Master mode (after enable edge)	12		

1. Values based on design simulation and/or characterization results, and not tested in production.
2. Min time is for the minimum time to drive the output and the max time is for the maximum time to validate the data.
3. Min time is for the minimum time to invalidate the output and the max time is for the maximum time to put the data in Hi-Z.

Figure 37. SPI timing diagram - slave mode and CPHA = 0

Figure 38. SPI timing diagram - slave mode and CPHA = 1⁽¹⁾

- Measurement points are done at CMOS levels: 0.3 V_{DD} and 0.7 V_{DD}.

Figure 40. Typical application with I²C bus and timing diagram

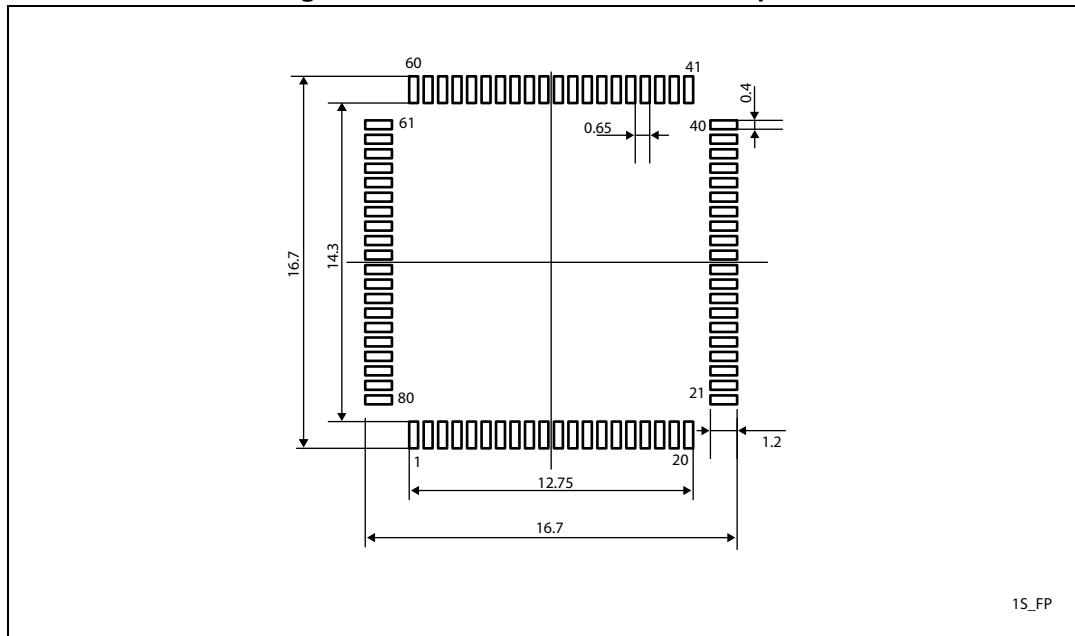
1. Measurement points are made at CMOS levels: $0.3 \times V_{DD}$ and $0.7 \times V_{DD}$

Table 51. LQFP80 - 80-pin, 14 x 14 mm low-profile quad flat package mechanical data⁽¹⁾ (continued)

Symbol	millimeters			inches		
	Min	Typ	Max	Min	Typ	Max
D	15.800	16.000	16.200	0.6220	0.6299	0.6378
D1	13.800	14.000	14.200	0.5433	0.5512	0.5591
D3	-	12.350	-	-	0.4862	-
E	15.800	16.000	16.200	0.6220	0.6299	0.6378
E1	13.800	14.000	14.200	0.5433	0.5512	0.5591
E3	-	12.350	-	-	0.4862	-
e	-	0.650	-	-	0.0256	-
L	0.450	0.600	0.750	0.0177	0.0236	0.0295
L1	-	1.000	-	-	0.0394	-
k	0°	3.5°	7°	0°	3.5°	7°
ccc	-	-	0.100	-	-	0.0039

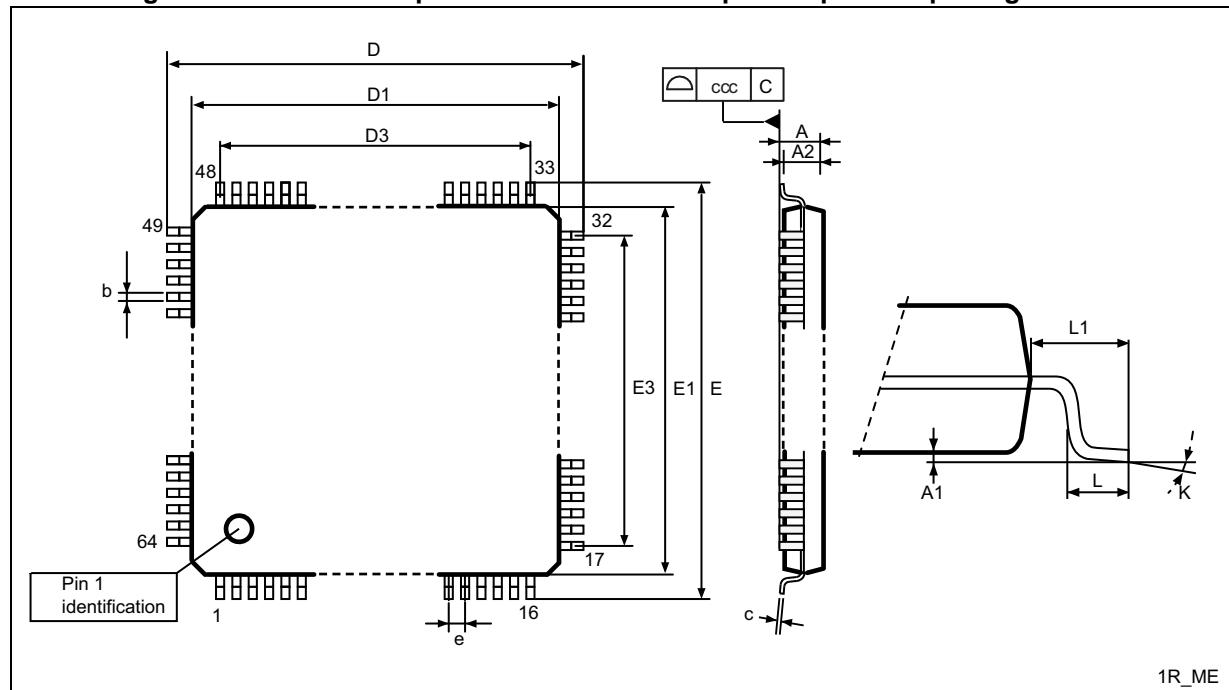
1. Values in inches are converted from mm and rounded to 4 decimal digits.

Figure 44. LQFP80 recommended footprint



11.1.2 LQFP64 package information

Figure 46. LQFP64 - 64-pin 14 mm x 14 mm low-profile quad flat package outline



1R_ME

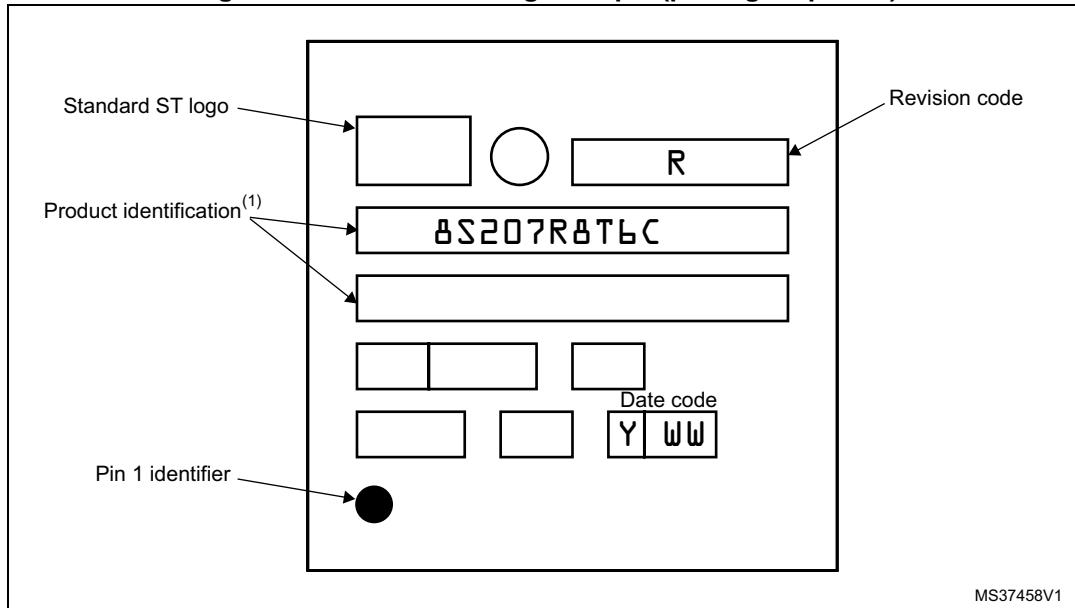
Table 52. LQFP64 - 64-pin, 14 x 14 mm low-profile quad flat package mechanical data

Symbol	mm			inches ⁽¹⁾		
	Min	Typ	Max	Min	Typ	Max
A			1.600			0.0630
A1	0.050		0.150	0.0020		0.0059
A2	1.350	1.400	1.450	0.0531	0.0551	0.0571
b	0.300	0.370	0.450	0.0118	0.0146	0.0177
C	0.090		0.200	0.0035		0.0079
D	15.800	16.000	16.200	0.6220	0.6299	0.6378
D1	13.800	14.000	14.200	0.5433	0.5512	0.5591
D3		12.000			0.4724	
E	15.800	16.000	16.200	0.6220	0.6299	0.6378
E1	13.800	14.000	14.200	0.5433	0.5512	0.5591
E3		12.000			0.4724	
e		0.800			0.0315	
L	0.450	0.600	0.750	0.0177	0.0236	0.0295
L1		1.000			0.0394	

Device marking

The following figure shows the marking for the LQFP64 package.

Figure 49. LQFP64 marking example (package top view)



1. Parts marked as "ES", "E" or accompanied by an Engineering Sample notification letter, are not yet qualified and therefore not yet ready to be used in production and any consequences deriving from such usage will not be at ST charge. In no event, ST will be liable for any customer usage of these engineering samples in production. ST Quality has to be contacted prior to any decision to use these Engineering samples to run qualification activity.

11.1.5 LQFP32 package information

Figure 56. LQFP32 - 32-pin, 7 x 7 mm low-profile quad flat package outline

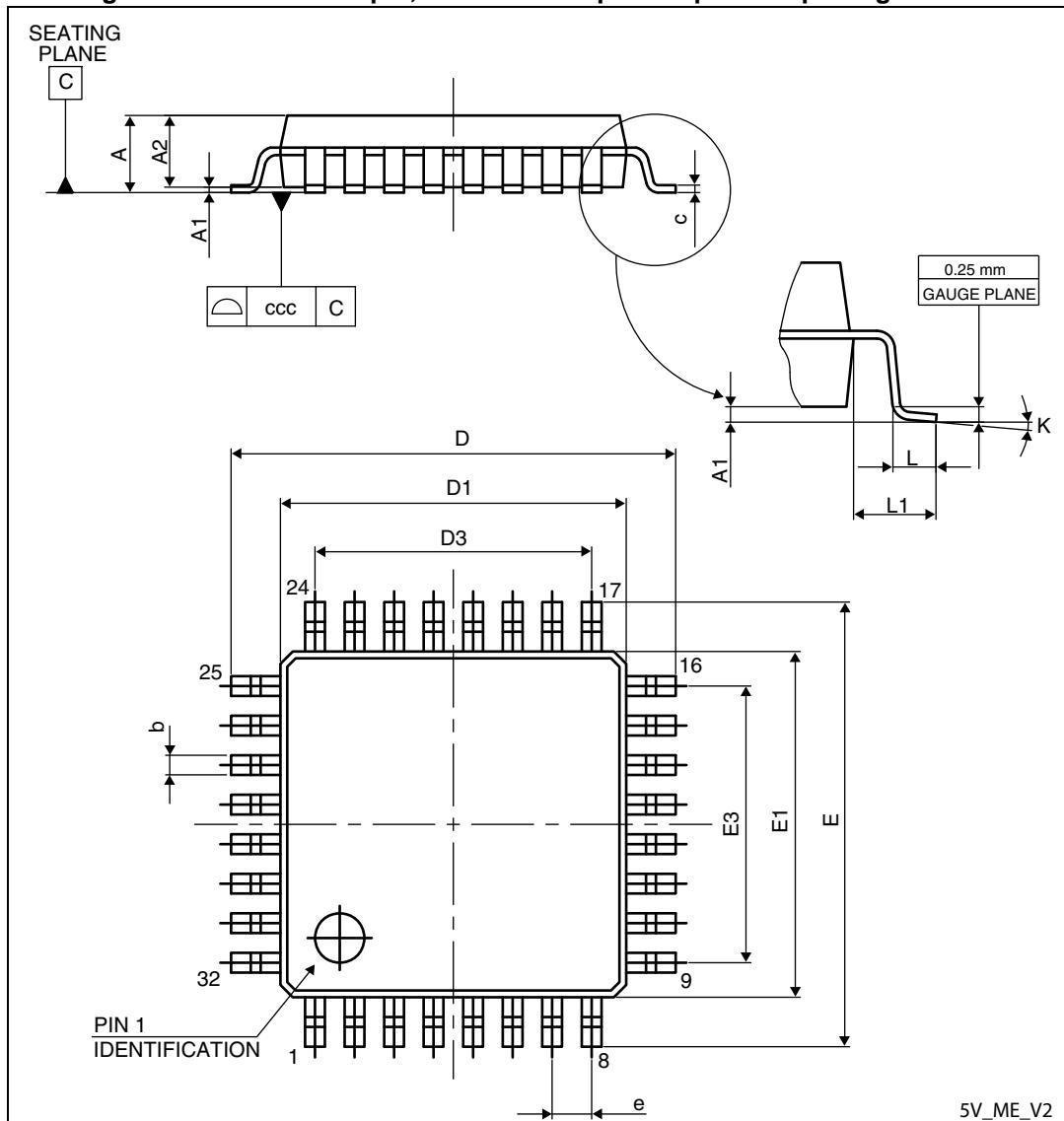
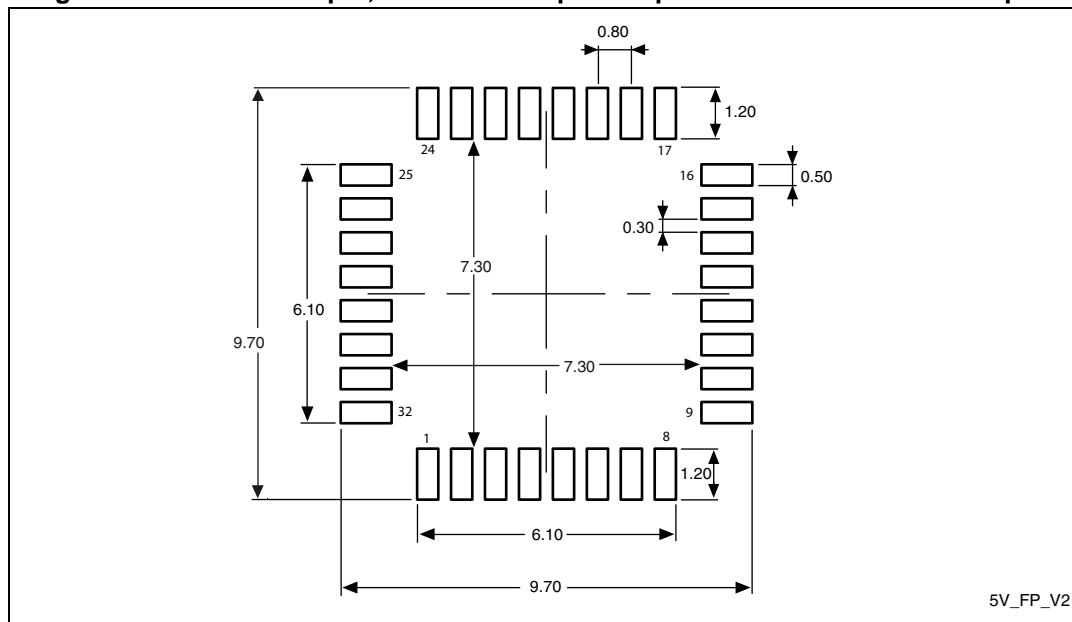


Table 56. LQFP32 - 32-pin, 7 x 7 mm low-profile quad flat package mechanical data

Symbol	mm			inches ⁽¹⁾		
	Min	Typ	Max	Min	Typ	Max
A	-	-	1.600	-	-	0.0630
A1	0.050	-	0.150	0.0020	-	0.0059
A2	1.350	1.400	1.450	0.0531	0.0551	0.0571
b	0.300	0.370	0.450	0.0118	0.0146	0.0177
c	0.090	-	0.200	0.0035	-	0.0079
D	8.800	9.000	9.200	0.3465	0.3543	0.3622
D1	6.800	7.000	7.200	0.2677	0.2756	0.2835
D3	-	5.600	-	-	0.2205	-
E	8.800	9.000	9.200	0.3465	0.3543	0.3622
E1	6.800	7.000	7.200	0.2677	0.2756	0.2835
E3	-	5.600	-	-	0.2205	-
e	-	0.800	-	-	0.0315	-
L	0.450	0.600	0.750	0.0177	0.0236	0.0295
L1	-	1.000	-	-	0.0394	-
k	0°	3.5°	7°	0°	3.5°	7°
ccc	-	-	0.100	-	-	0.0039

1. Values in inches are converted from mm and rounded to four decimal places.

Figure 57. LQFP32 - 32-pin, 7 x 7 mm low-profile quad flat recommended footprint

1. Dimensions are expressed in millimeters.